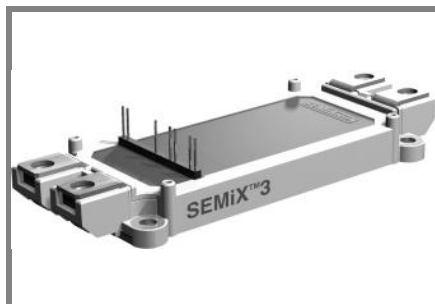


# SEMiX 453GB176HD



SEMiX® 3

## Trench IGBT Modules

### SEMiX 453GB176HD

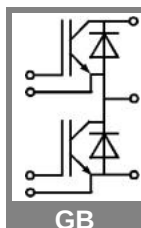
#### Preliminary Data

#### Features

- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$  with positive temperature coefficient
- High short circuit capability

#### Typical Applications

- AC inverter drives
- UPS
- Electronic welders



| Absolute Maximum Ratings |                                                   | $T_c = 25\text{ °C}$ , unless otherwise specified |       |
|--------------------------|---------------------------------------------------|---------------------------------------------------|-------|
| Symbol                   | Conditions                                        | Values                                            | Units |
| <b>IGBT</b>              |                                                   |                                                   |       |
| $V_{CES}$                |                                                   | 1700                                              | V     |
| $I_C$                    | $T_c = 25\text{ (80) °C}$                         | 450 (320)                                         | A     |
| $I_{CRM}$                | $t_p = 1\text{ ms}$                               | 600                                               | A     |
| $V_{GES}$                |                                                   | $\pm 20$                                          | V     |
| $T_{vj}$ ( $T_{stg}$ )   | $T_{OPERATION} \leq T_{stg}$                      | - 40 ... + 150 (125)                              | °C    |
| $V_{isol}$               | AC, 1 min.                                        | 4000                                              | V     |
| <b>Inverse diode</b>     |                                                   |                                                   |       |
| $I_F$                    | $T_c = 25\text{ (80) °C}$                         | 500 (340)                                         | A     |
| $I_{FRM}$                | $t_p = 1\text{ ms}$                               | 600                                               | A     |
| $I_{FSM}$                | $t_p = 10\text{ ms}$ ; sin.; $T_j = 25\text{ °C}$ | 2900                                              | A     |

| Characteristics                |                                                                                                 | $T_c = 25\text{ °C}$ , unless otherwise specified |            |            |       |
|--------------------------------|-------------------------------------------------------------------------------------------------|---------------------------------------------------|------------|------------|-------|
| Symbol                         | Conditions                                                                                      | min.                                              | typ.       | max.       | Units |
| <b>IGBT</b>                    |                                                                                                 |                                                   |            |            |       |
| $V_{GE(th)}$                   | $V_{GE} = V_{CE}$ , $I_C = 12\text{ mA}$                                                        | 5,2                                               | 5,8        | 6,4        | V     |
| $I_{CES}$                      | $V_{GE} = 0$ , $V_{CE} = V_{CES}$ , $T_j = 25\text{ ( ) °C}$                                    |                                                   |            | 0,45       | mA    |
| $V_{CE(TO)}$                   | $T_j = 25\text{ (125) °C}$                                                                      |                                                   | 1 (0,9)    | 1,2 (1,1)  | V     |
| $r_{CE}$                       | $V_{GE} = 0\text{ V}$ , $T_j = 25\text{ (125) °C}$                                              |                                                   | 3,3 (5,2)  | 4,2 (6)    | mΩ    |
| $V_{CE(sat)}$                  | $I_{Cnom} = 300\text{ A}$ , $V_{GE} = 15\text{ V}$ ,<br>$T_j = 25\text{ (125) °C}$ , chip level |                                                   | 2 (2,45)   | 2,45 (2,9) | V     |
| $C_{ies}$                      | under following conditions                                                                      |                                                   | 21,3       |            | nF    |
| $C_{oes}$                      | $V_{GE} = 0$ , $V_{CE} = 25\text{ V}$ , $f = 1\text{ MHz}$                                      |                                                   | 1,1        |            | nF    |
| $C_{res}$                      |                                                                                                 |                                                   | 0,9        |            | nF    |
| $L_{CE}$                       |                                                                                                 |                                                   | 20         |            | nH    |
| $R_{CC+EE'}$                   | terminal-chip, $T_c = 25\text{ (125) °C}$                                                       |                                                   | 0,7 (1)    |            | mΩ    |
| $t_{d(on)}/t_r$                | $V_{CC} = 1200\text{ V}$ , $I_{Cnom} = 300\text{ A}$                                            |                                                   | 335 / 70   |            | ns    |
| $t_{d(off)}/t_f$               | $V_{GE} = \pm 15\text{ V}$                                                                      |                                                   | 990 / 150  |            | ns    |
| $E_{on}$ ( $E_{off}$ )         | $R_{Gon} = R_{Goff} = 4,3\text{ Ω}$ , $T_j = 125\text{ °C}$                                     |                                                   | 195 (115)  |            | mJ    |
| <b>Inverse diode</b>           |                                                                                                 |                                                   |            |            |       |
| $V_F = V_{EC}$                 | $I_{Fnom} = 300\text{ A}$ ; $V_{GE} = 0\text{ V}$ ; $T_j = 25\text{ (125) °C}$ , chip level     |                                                   | 1,6 (1,6)  | 1,8 (1,8)  | V     |
| $V_{(TO)}$                     | $T_j = 25\text{ (125) °C}$                                                                      |                                                   | 1,1 (0,9)  | 1,3 (1,1)  | V     |
| $r_T$                          | $T_j = 25\text{ (125) °C}$                                                                      |                                                   | 1,7 (2,3)  | 1,7 (2,3)  | mΩ    |
| $I_{RRM}$                      | $I_{Fnom} = 300\text{ A}$ ; $T_j = 25\text{ (125) °C}$                                          |                                                   | (350)      |            | A     |
| $Q_{rr}$                       | $di/dt = 4700\text{ A/μs}$                                                                      |                                                   | (115)      |            | μC    |
| $E_{rr}$                       | $V_{GE} = -15\text{ V}$                                                                         |                                                   | (65)       |            | mJ    |
| <b>Thermal characteristics</b> |                                                                                                 |                                                   |            |            |       |
| $R_{th(j-c)}$                  | per IGBT                                                                                        |                                                   |            | 0,06       | K/W   |
| $R_{th(j-c)D}$                 | per Inverse Diode                                                                               |                                                   |            | 0,12       | K/W   |
| $R_{th(j-c)FD}$                | per FWD                                                                                         |                                                   |            |            | K/W   |
| $R_{th(c-s)}$                  | per module                                                                                      |                                                   | 0,04       |            | K/W   |
| <b>Temperature sensor</b>      |                                                                                                 |                                                   |            |            |       |
| $R_{25}$                       | $T_c = 25\text{ °C}$                                                                            |                                                   | 5 $\pm$ 5% |            | kΩ    |
| $B_{25/85}$                    | $R_2 = R_1 \exp[B(1/T_2 - 1/T_1)]$ ; $T[K]; B$                                                  |                                                   | 3420       |            | K     |
| <b>Mechanical data</b>         |                                                                                                 |                                                   |            |            |       |
| $M_s/M_t$                      | to heatsink (M5) / for terminals (M6)                                                           | 3/2,5                                             |            | 5 / 5      | Nm    |
| w                              |                                                                                                 |                                                   | 289        |            | g     |

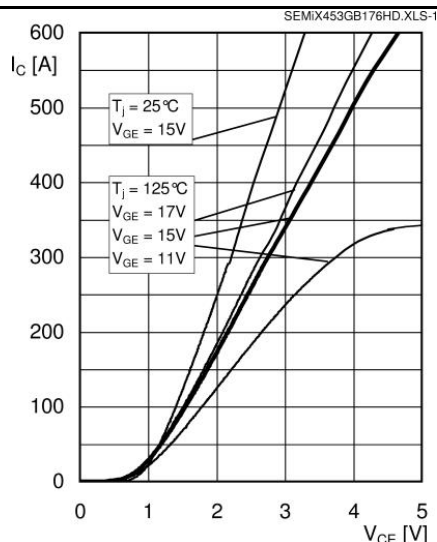


Fig. 1 Typ. output characteristic, inclusive  $R_{CC'+EE'}$

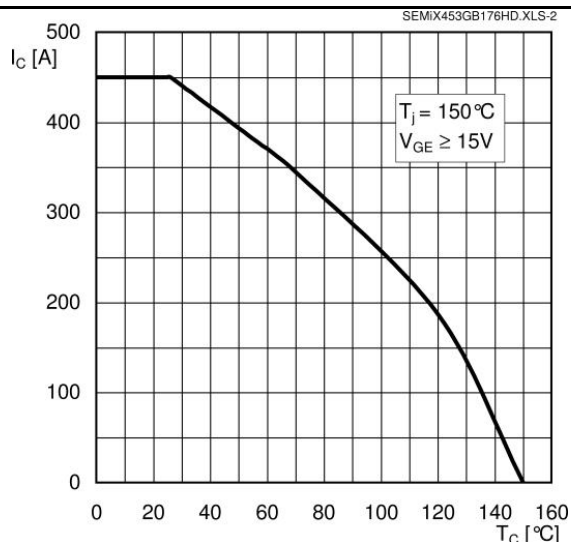


Fig. 2 Rated current vs. temperature  $I_C = f(T_C)$

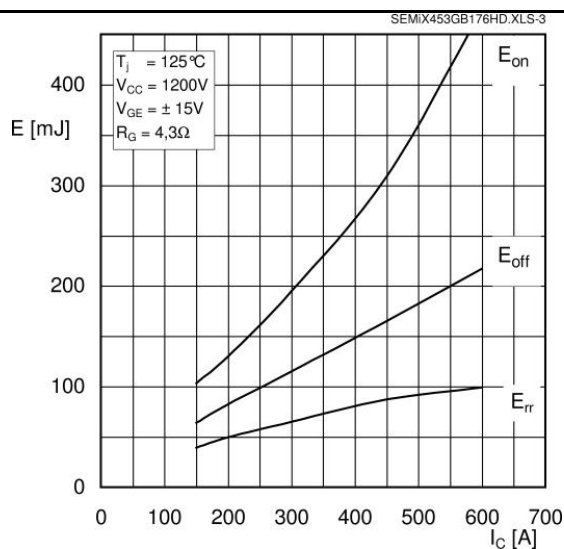


Fig. 3 Typ. turn-on /off energy =  $f(I_C)$

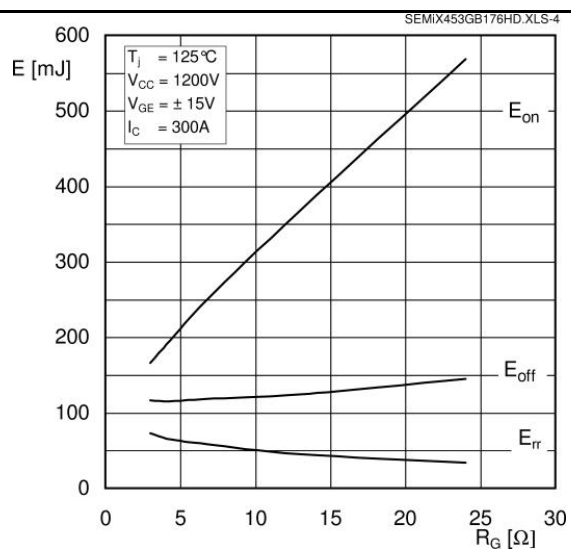


Fig. 4 Typ. turn-on /off energy =  $f(R_G)$

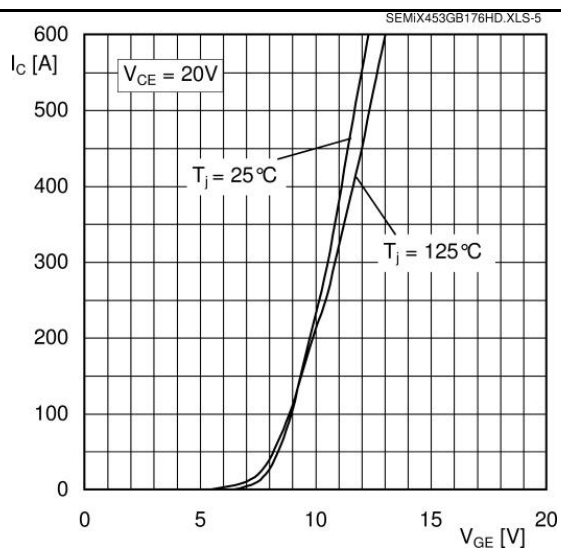


Fig. 5 Typ. transfer characteristic

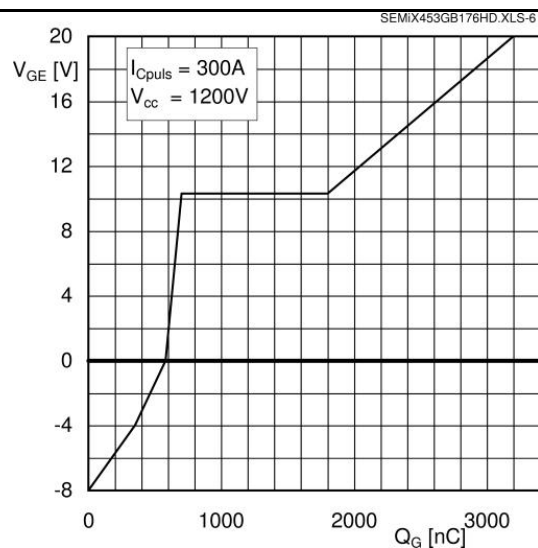
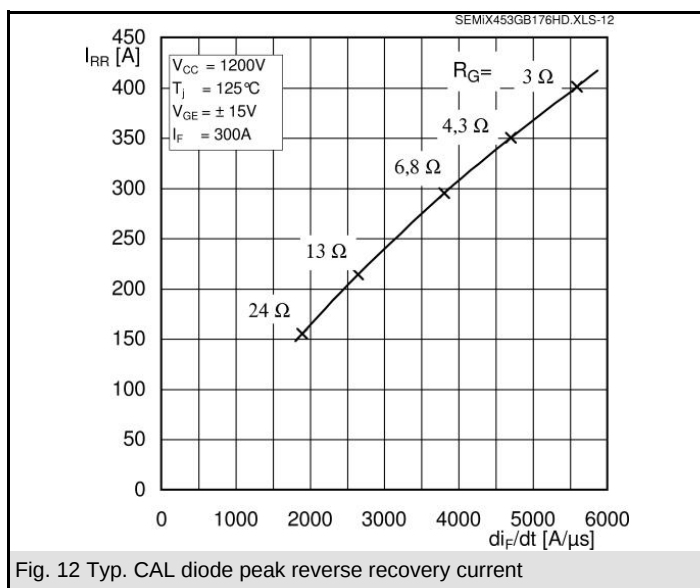
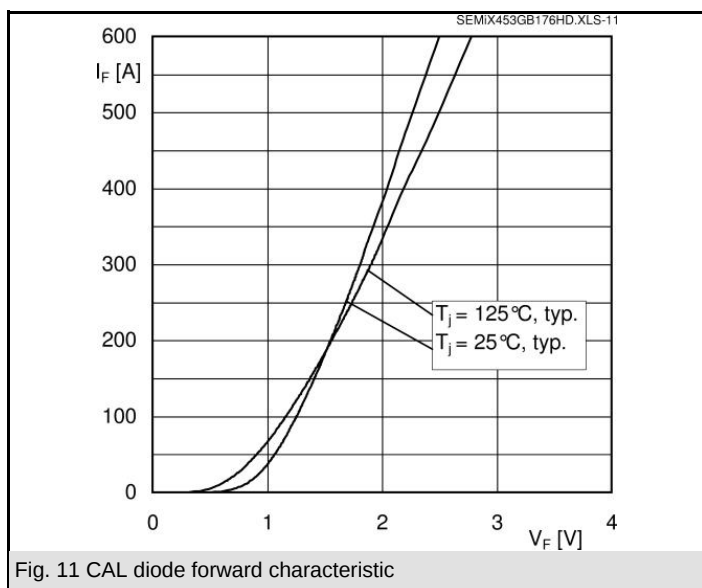
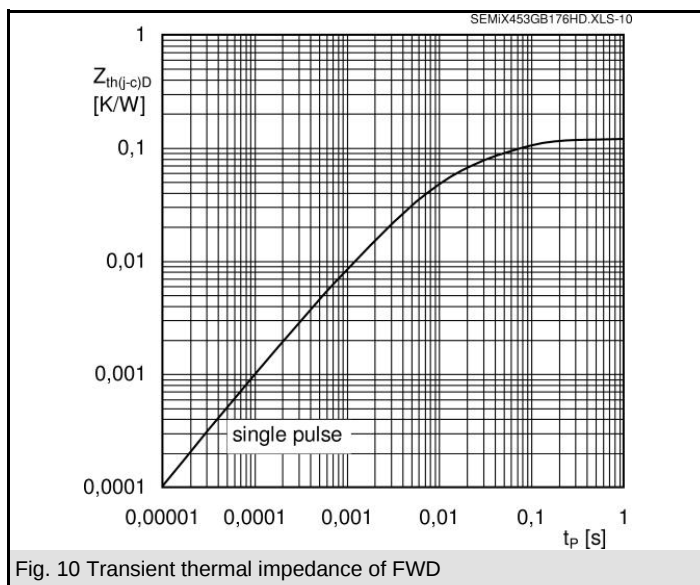
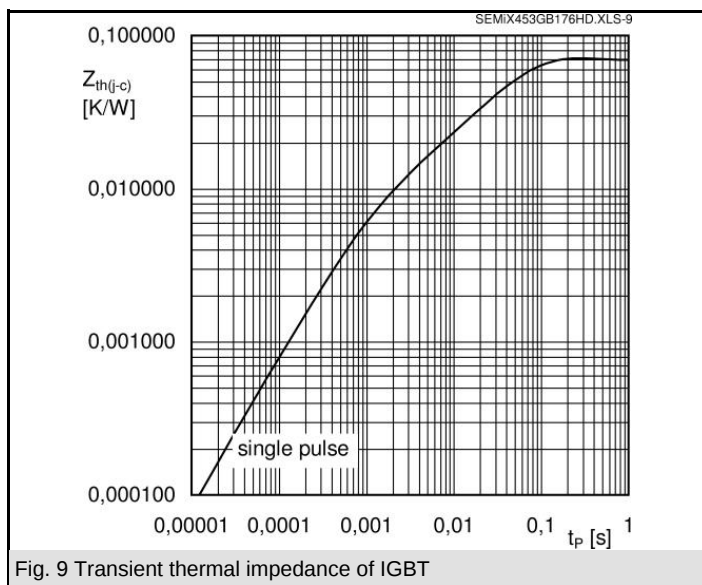
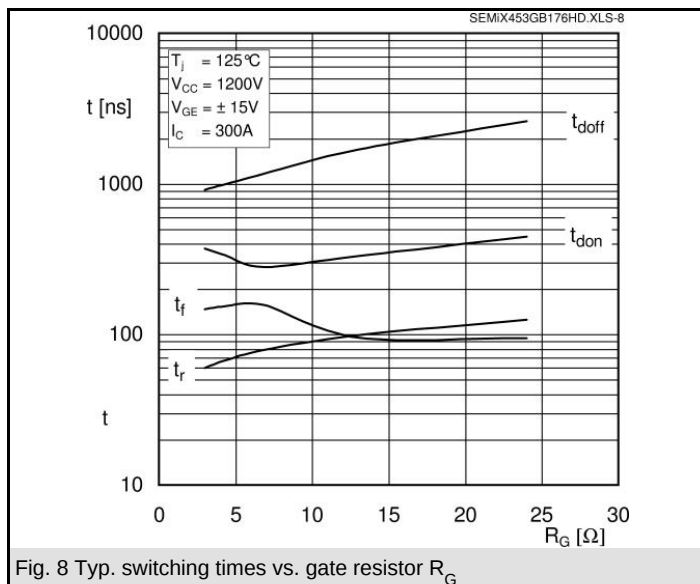
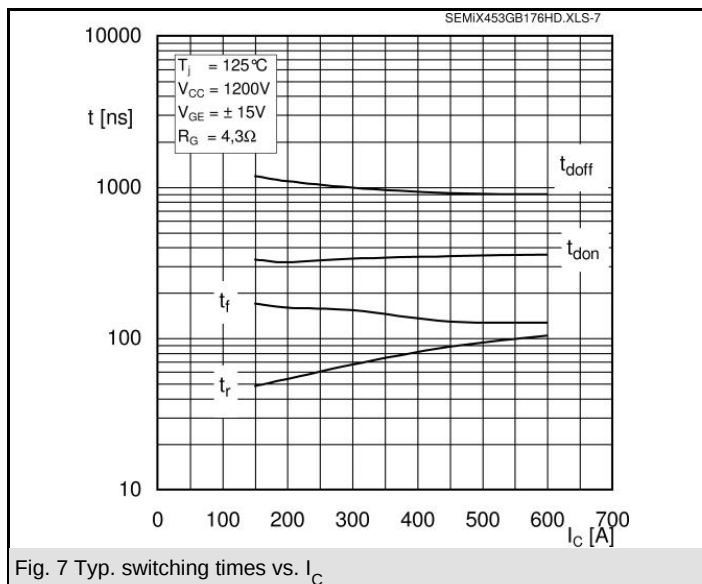
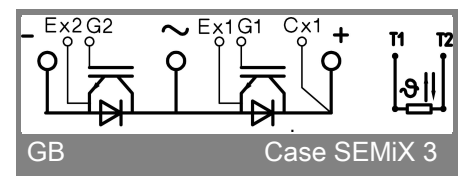
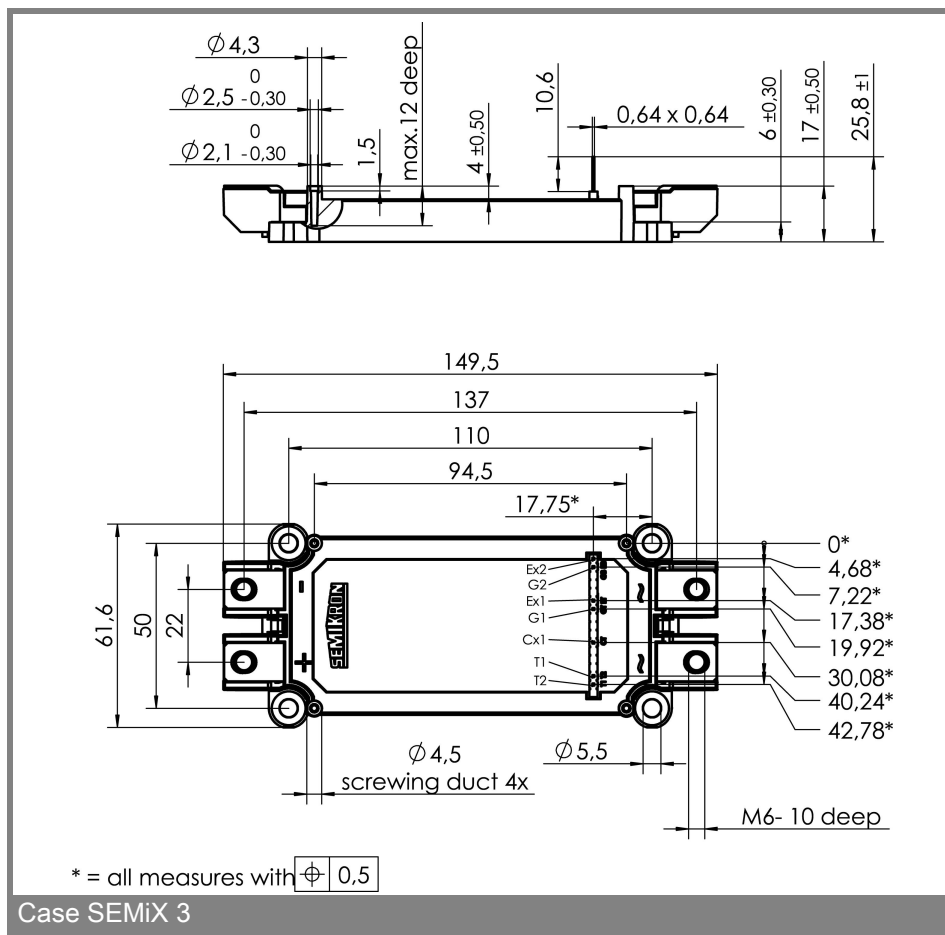
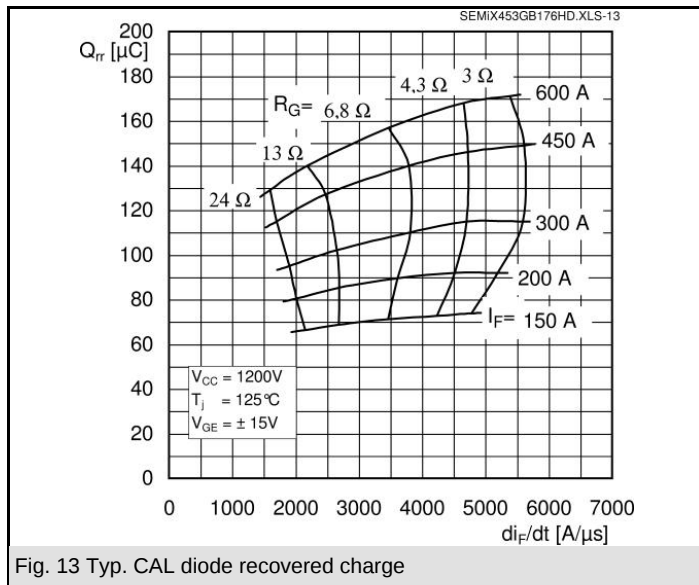


Fig. 6 Typ. gate charge characteristic





This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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